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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

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Sheet 1 of 7

Complete if Known

Application Number	Unknown
Filing Date	(Herewith)
First Named Inventor	W. Thomas Cathey, Jr.
Art Unit	Unknown
Examiner Name	Unknown
Attorney Docket Number	414671

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number - Kind Code ² (if known)			
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	2	3,054,898	09-18-1962	Westover et al.	
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Sheet 2 of 7

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Art Unit	Unknown
Examiner Name	Unknown
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		Number - Kind Code ² (if known)			
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First Named Inventor	W. Thomas Cathey, Jr.
Art Unit	Unknown
Examiner Name	Unknown
Attorney Docket Number	414671

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		Number - Kind Code ² (if known)			
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		Country Code ³ - Number ⁴ - Kind Code ⁵ (if known)				
	1	EPO-0759573-A2	02-26-1997	Eastman Kodak Company		
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	5	EPO-0584769-B1	3-2-1994	Matsushita Electric Industrial Co., Ltd.		
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	8	EP-0742466-A	11-13-1996	Johnson & Johnson Vision		

Examiner Signature		Date Considered	1-23-2008
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Sheet 4 of 7

Complete if Known

Application Number	Unknown
Filing Date	(Herewith)
First Named Inventor	W. Thomas Cathey, Jr.
Art Unit	Unknown
Examiner Name	Unknown
Attorney Docket Number	414671

NON PATENT LITERATURE DOCUMENTS

Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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Sheet 5

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First Named Inventor	W. Thomas Cathey, Jr.
Art Unit	Unknown
Examiner Name	Unknown
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	16	W. T. CATHEY, B. R. FRIEDEN, W. T. RHODES, and C. K. RUSHFORTH, "Image gathering and processing for enhanced resolution", J. Opt. Soc. Am. A, Vol. 1, No. 3, p 241-250, March 1984	
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	32	J.T. MCCRICKERD, "Coherent processing and depth of focus of annular aperture imagery", Applied Optics, Vol. 10, No. 10, p2226-2230, October, 1971	
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Examiner Signature	Date Considered		1-23-2008

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Sheet 7 of 7

Complete if Known

Application Number	Unknown
Filing Date	(Herewith)
First Named Inventor	W. Thomas Cathey, Jr.
Art Unit	Unknown
Examiner Name	Unknown
Attorney Docket Number	414671

NON PATENT LITERATURE DOCUMENTS

Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	48	SIEBERT, J. (Officer), International Search Report received in PCT/US01/26126, international filing date 08-20-2001, Completion Date 24 June 2003, 3 pages.S	
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